

Application No.	Applicant(s)	
09/902,227	HERSCH ET AL.	
Examiner	Art Unit	
Dennis Rosario	2621	

	SEAR	CHED			
Class	Subclass	Oa	10	Exc	miner
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382	293-244	1913	106		(SE)
	301,702)			
	306,308			Ŀ	
,	242,240				
	135,137				
	138,140		·		
	100,767			Ĺ	
345	588,640	1	217/0	7	DR
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	606,955	. — 1			1_
	(32,949			L	
	636,638			L	
	646,473		<u>V</u>		V

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Class	Subclass	Cate	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
(uparted)	DATE	EXMR	
Est Search-all	03/22/05	DR	
IEEE Seach	(3120/06)	16.7	
(polated) - (clither	03/21/05	V	
or half-tone) near	[3/24/%]	(DR)	
map-)			
(microstructure or		(0.0)	
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and dither or			
halPtone)	710016	(00)	
(microstructure and (animation or vides)	3122/06)	עאן	
ACM search -			
Wersch	3/22/06	DR	
- micro structure			
tanimat * + dither			
- Wersch +animation	13/21/9	DR	
(Fall)	(2/5/07 (3/13/06)	(CR)	
(East) all dB		DR	
video) and (dille	10113146	. ~	
or halflon*)-			
ACM - + blendat shape	2/7/07	DR	
+dither =			

Search I	Notes ((continued

Application/Control No.	Applicant(s)/Par Reexamination	ent under
09/902,227	HERSCH ET A	L.
Examiner	Art Unit	
Dennis Rosario	2621	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
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IEEE-shape (neir > blend+-	217/07	吹
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